United States Department of Commerce National Institute of Standards and Technology



Certificate of Accreditation to ISO/IEC 17025:2017

NVLAP LAB CODE: 200012-0

IPS Corporation Nagano Calibration Center

Nagano-ken Japan

is accredited by the National Voluntary Laboratory Accreditation Program for specific services, listed on the Scope of Accreditation, for:

Calibration Laboratories

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017.

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communique dated January 2009).

2019-12-09 through 2020-12-31

Effective Dates



For the National Voluntary Laboratory Accreditation Program



CALIBRATION LABORATORIES

NVLAP LAB CODE 200012-0

SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017

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Fields of Calibration

Electromagnetics – DC/Low Frequency
Time and Frequency
Electromagnetics – RF/Microwave

CALIBRATION AND MEASUREMENT CAPABILITIES (CMC) Notes 1,2

| Measured Parameter or | | Expanded | |
|-------------------------------------|-----------------------------|-------------------------------|-----------------------------|
| Device Calibrated | Range | Uncertainty Notes 3, 5 | Remarks |
| EL | ECTROMAGNETICS - | - DC/LOW FREQUENCY | |
| AC RESISTANCE and CURRE | NT (20/E02) | | |
| AC Current – Measure | | | |
| ESD Simulators | | | IEC 61000-4-2, ISO 10605 |
| Peak current (2 kV to 30 kV) | 7.5 A to 113 A | 3.9 % | Oscilloscope |
| Discharge current | | | |
| (30 ns to 800 ns) | 0.3 A to 60 A | 4.9 % | |
| | | | |
| Surge Generator | | | IEC 61000-4-5 |
| Field calibrations available Note 4 | | | |
| Peak Current, Short circuit | | | |
| current waveform | | | |
| (rise time/duration: 8/20 μs | XX | 2.504 | 0 11 |
| or 5/320 μs) | Up to 2 kA | 2.6 % | Oscilloscope |
| AC Resistance | | | |
| Field calibrations available Note 4 | | | |
| 50 Hz to 1 kHz | 0.04Ω to 1 Ω | 5.6 % | LCR Meter |
| 50 HZ to 1 kHZ | 0.04 \$2 to 1 \$2 | 3.0 % | LCK Meter |
| | | | Oscilloscope, Current Coil, |
| 50 Hz, 60 Hz | 0.04Ω to 1Ω | 5.1 % | HV Probe |
| 30 112, 00 112 | 0.012210122 | 5.1 /0 | 11, 11000 |
| Inductance | | | |
| Field calibrations available Note 4 | | | |
| 50 Hz to 1 kHz | Up to 1 H | 5.6 % | LCR Meter |

2019-12-09 through 2020-12-31

Effective dates

For the National Voluntary Laboratory Accreditation Program

Page 1 of 12



CALIBRATION LABORATORIES

NVLAP LAB CODE 200012-0

| 50 Hz, 60 Hz | Up to 1 H | 5.1 % | Oscilloscope, Current Coil, HV Probe |
|--|---|-----------------|---|
| Reactance (X _L) Field calibrations available Note 4 50 Hz to 1 kHz | 0.04 Ω to 1 Ω | 5.5 % | LCR Meter |
| | | | Oscilloscope, Current Coil, |
| 50 Hz, 60 Hz | $0.04~\Omega$ to $1~\Omega$ | 5.1 % | HV Probe |
| Capacitance Field calibrations available Note 4 | | | |
| 50 Hz to 1 kHz | Up to 1 μF | 5.4 % | LCR Meter |
| DC VOLTAGE (20/E06) | | | |
| DC Voltage - Measure Field calibrations available Note 4 | 0.01 V to 1000 V | 0.11 % | DMM |
| ESD Simulators | | | IEC 61000-4-2, ISO 10605 |
| DC High Voltage | 0.5 kV to 1 kV 1 kV to 3 kV | 2.3 % 1.2 % | DHM-40/10 |
| | 3 kV to 40 kV | 1.2 % | |
| LF AC VOLTAGE (20/E09) | | | |
| AC Voltage - Measure Field calibrations available Note 4 | | | |
| 0.1 V to 750 V | 3 Hz to 5 Hz 5 Hz to 10 Hz | 3.1 % 0.46 % | DMM |
| | 10 Hz to 20 kHz | 0.12 % | |
| | 20 kHz to 50 kHz | 0.18 % | |
| | 50 kHz to 100 kHz 100 kHz to 300 kHz | 0.79 % 5.2 % | |
| | 100 K112 to 300 K112 | 3.2 /0 | |
| 10 mV to 5 V | DC to 100 MHz | 3.3 % | Oscilloscope |
| 5 V to 4 kV | DC to 50 MHz | 3.8 % | Oscilloscope, HV Probe |
| EFT/Burst | | | IEC 61000-4-4 |
| Field calibrations available Note 4 | 100 V to 6 kV | 3.0 % | Oscilloscope, Attenuator |

2019-12-09 through 2020-12-31

Effective dates

For the National Voluntary Laboratory Accreditation Program

Page 2 of 12



CALIBRATION LABORATORIES

NVLAP LAB CODE 200012-0

| Peak Voltage | | | |
|---|------------------|----------|--------------------------|
| - | | | |
| Peak Voltage with capacitive | | 2.8 % | |
| clamp | | 2.8 % | |
| Transient Generator | | | ISO 7637-2, Annex C |
| Field calibrations available Note 4 | 10 11 | 4.1.07 | |
| Peak Voltage | 10 V to 600 V | 4.1 % | |
| Surge Generator | | | IEC 61000-4-5 |
| Field calibrations available Note 4 | | | |
| Peak Voltage, Open-circuit | | | |
| voltage waveform (1.2/50 μs, 10/700 μs) | Up to 4 kV | 2.8 % | Oscilloscope, HV Probe |
| (1.2/20 με, 10/700 με) | CP to TRY | 2.0 /0 | Osemoscope, II v I I obe |
| Overshoot/Undershoot | | | Oscilloscope, HV Probe |
| Field calibrations available Note 4 Voltage | 1 V to 50 V | 3.2 % | |
| Voltage | 1 V to 50 V | 3.2 70 | |
| | | | |
| With Direct Lie | | | |
| Voltage Dip Simulator Field calibrations available Note 4 | | | |
| AC Voltage | 10 V to 500 V | 0.4 % | DMM |
| | | | |
| | | | |
| | TIME and F | REQUENCY | |
| FREQUENCY DISSEMINATION | | | |
| EFT/Burst (100 V to 6 kV) | | | IEC 61000-4-4 |
| Field calibrations available Note 4 Repetition frequency | 1 kHz to 500 kHz | 0.6 % | Oscilloscope, Attenuator |
| Burst duration | 0.5 ms to 20 ms | 0.6 % | |
| Burst period | 100 ms to 500 ms | 0.4 % | |
| Walter Die Circ 1 | | | |
| Voltage Dip Simulator Field calibrations available Note 4 | | | |
| Duration Time | 10 ms to 5 s | 2.4 % | Oscilloscope |
| | | | • |
| Frequency - Measure | 1 Hz to 1 GHz | 0.5 % | Oscilloscope |

2019-12-09 through 2020-12-31

Effective dates

For the National Voluntary Laboratory Accreditation Program

Page 3 of 12



CALIBRATION LABORATORIES

NVLAP LAB CODE 200012-0

| Field calibrations available Note 4 | 50 Hz / 60 Hz | 0.1 % | DMM |
|--|--|----------------------------------|---|
| Differential - Time Measure Field calibrations available Note 4 | 1 ns to 5 s | 0.6 % | Oscilloscope |
| Differential - Phase Field calibrations available Note 4 | 0° to 360° | 2.5° | Oscilloscope |
| PULSE WAVEFORM (20/F04) | | | |
| ESD Simulators (2 kV to 30 kV) Rise time | 0.6 ns to 1 ns | 6.9 % | IEC 61000-4-2, ISO 10605 (Excluding RC time constant) Oscilloscope |
| EFT/Burst (100 V to 6 kV) Field calibrations available Note 4 Without Capacitive Clamp Rise time Impulse duration With Capacitive Clamp Rise time Impulse duration | 1 ns to 10 ns 10 ns to 500 ns 1 ns to 10 ns 10 ns to 500 ns | 1.5 % 1.0 % 1.4 % 0.6 % | IEC 61000-4-4 Oscilloscope, Attenuator |
| Surge Generator Field calibrations available Note 4 Open-circuit voltage waveform (100 V to 4 kV) (Rise time/duration: 1.2/50 µs or 10/700 µs) | | | IEC 61000-4-5 |
| Rise Time Half value duration | 0.5 μs to 20 μs 10 μs to 1000 μs | 3.5 % 3.7 % | Oscilloscope, HV Probe |
| Short-circuit current waveform | | | |

2019-12-09 through 2020-12-31

Effective dates

For the National Voluntary Laboratory Accreditation Program

Page 4 of 12 NVLAP-02S (REV. 2011-08-16)



CALIBRATION LABORATORIES

NVLAP LAB CODE 200012-0

| (50 A to 2 kA) (Rise time/duration: 8/20 μs or 5/320 μs) Rise Time Half value duration | 1 μs to 20 μs 10 μs to 500 μs | 3.4 % 2.3 % | |
|--|--|--|---|
| Transient Generator (10 V to 600 V) Field calibrations available Note 4 Rise Time Pulse Width | 1 ns to 50 ms 50 ns to 3 s | 5.8 % 5.9 % | ISO 7637-2, Annex C Oscilloscope |
| Voltage Dip Simulator (10 V to 500 V; 50 Hz or 60 Hz) Field calibrations available Note 4 Rise/Fall Time | 1 μs to 5 μs | 2.7 % | IEC 61000-4-11 Oscilloscope |
| | | CS – RF/MICROWAVE | |
| MICROWAVE ANTENNA PAR | RAMETERS (20/R08) | T | |
| Dipole Antenna (such as the VHA9103/UHA9105) Horizontal Antenna Factor (D = 10 m, H = 2 m) | 30 MHz to 80 MHz (Tuned at 80 MHz) 30 MHz to 300 MHz 300 MHz to 1 GHz | 0.6 dB 0.6 dB 0.8 dB | Substitution method Network Analyzer |
| Biconical Antenna, Antenna Factor Horizontal (D = 10 m, H = 2 m) Horizontal (D = 3 m, H = 2 m) Horizontal (D = 3 m, H = 1 m) Vertical (D = 3 m, H = 1.5 m) Vertical (D = 3 m, H = 1 m) | 30 MHz to 300 MHz | 0.7 dB 0.6 dB 0.7 dB 0.8 dB 0.9 dB | Substitution method Network Analyzer |
| Log-Periodic Antenna Antenna Factor Horizontal (D = 10 m, H = 2 m) Horizontal (D = 3 m, H = 2 m) | 200 MHz to 1 GHz | 1.1 dB 1.1 dB | Substitution method Network Analyzer |

2019-12-09 through 2020-12-31

Effective dates

For the National Voluntary Laboratory Accreditation Program

Page 5 of 12



CALIBRATION LABORATORIES

NVLAP LAB CODE 200012-0

| Horizontal (D = 3 m, H = 1 m) Vertical (D = 3 m, H = 1.5 m) Vertical (D = 3 m, H = 1 m) | | 1.1 dB 1.1 dB 1.2 dB | |
|--|--|--|---|
| Bi-log Antenna Horizontal Antenna Factor (D = 10 m, H = 2 m) (D = 3 m, H = 2 m) | 30 MHz to 1 GHz | 1.3 dB 1.3 dB | Substitution method Network Analyzer |
| Biconical Antenna Antenna Factor Horizontal (D = 1 m, H = 3 m) Vertical (D = 1 m, H = 3 m) | 25 MHz to 300 MHz | 0.9 dB 0.8 dB | SAE ARP958 Network Analyzer |
| Log-Periodic Antenna | | | SAE ARP958 |
| Antenna Factor Horizontal (D = 1 m, H = 3 m) Horizontal (D = 1 m, H = 3 m) Horizontal (D = 1 m, H = 3 m) Vertical (D = 1 m, H = 3 m) Vertical (D = 1 m, H = 3 m) Vertical (D = 1 m, H = 3 m) | 150 MHz to 300 MHz 300 MHz to 1 GHz 1 GHz to 1.8 GHz 150 MHz to 300 MHz 300 MHz to 1 GHz 1 GHz to 1.8 GHz | 0.8 dB 0.5 dB 0.7 dB 0.6 dB 0.5 dB 0.6 dB | Network Analyzer |
| Horn Antenna Antenna Factor Free Space (D = 1 m, H = 3 m) | 0.75 GHz to 8.5 GHz 0.75 GHz to 18 GHz | 1.0 dB 1.4 dB | SAE ARP958 Network Analyzer Spectrum Analyzer |
| NSA Measurement Field calibrations available Note 4 Horizontal Vertical Horizontal Vertical | 30 MHz to 200 MHz 200 MHz to 1 GHz | 1.4 dB 1.7 dB 1.4 dB 1.5 dB | CISPR 16-1-4, and ANSI C63.4 Network Analyzer |
| SVSWR Measurement Field calibrations available Note 4 | | | CISPR 16-1-4, and ANSI C63.4 Network Analyzer |

2019-12-09 through 2020-12-31

Effective dates

For the National Voluntary Laboratory Accreditation Program

Page 6 of 12



CALIBRATION LABORATORIES

NVLAP LAB CODE 200012-0

| Horizontal Vertical Horizontal Vertical Horizontal Vertical Horizontal Vertical Horizontal Vertical | 1 GHz to 3 GHz 3 GHz to 6 GHz 6 GHz to 12 GHz 12 GHz to 18 GHz | 2.2 dB 2.1 dB 2.4 dB 2.7 dB 2.5dB 1.9 dB 2.0 dB 1.9 dB | Spectrum Analyzer |
|--|--|--|---|
| Absorbing Clamp Clamp Factor Decoupling Factor (DF) Decoupling Factor (DR) | 30 MHz to 300 MHz 300 MHz to 1 GHz 30 MHz to 150 MHz 150 MHz to 1 GHz 30 MHz to 150 MHz 150 MHz to 1 GHz | 0.8 dB 1.1 dB 1.3 dB 4.4 dB 0.9 dB 6.1 dB | CISPR 16-1-3 Original Method Network Analyzer |
| Biconical, Log-periodic, Hybrid Antenna Horizontal Antenna Factor (D = 10 m, H = 2 m) | 30 MHz to 300 MHz 300 MHz to 1 GHz | 1.1 dB 0.9 dB | Standard Site Method ANSI C63.5 , CISPR 16-1-6 (OATS Calibration) |
| Horizontal Antenna Factor $(D = 10 \text{ m}, H = 1 \text{ m})$ Vertical Antenna Factor $(D = 10 \text{ m}, H = 1 \text{ m})$ Vertical Antenna Factor $(D = 10 \text{ m}, H = 1.5 \text{ m})$ | 30 MHz to 300 MHz 300 MHz to 1 GHz 30 MHz to 300 MHz 300 MHz to 1 GHz 30 MHz to 300 MHz 300 MHz to 1 GHz | 1.3 dB 1.1 dB 1.4 dB 1.5 dB 1.3 dB 1.2 dB | |
| Horizontal Antenna Factor $(D = 3 \text{ m}, H = 2 \text{ m})$ Horizontal Antenna Factor $(D = 3 \text{ m}, H = 1 \text{ m})$ Vertical Antenna Factor $(D = 3 \text{ m}, H = 1 \text{ m})$ Vertical Antenna Factor $(D = 3 \text{ m}, H = 1.5 \text{ m})$ | 30 MHz to 300 MHz 300 MHz to 1 GHz 30 MHz to 300 MHz 300 MHz to 1 GHz 30 MHz to 300 MHz 300 MHz to 1 GHz 30 MHz to 300 MHz 300 MHz to 1 GHz | 1.1 dB 1.0 dB 1.3 dB 1.1 dB 1.3 dB 1.5 dB 1.2 dB 1.2 dB | |

2019-12-09 through 2020-12-31

Effective dates

For the National Voluntary Laboratory Accreditation Program

Page 7 of 12



CALIBRATION LABORATORIES

NVLAP LAB CODE 200012-0

| | 1 | T | |
|---|--|--|--|
| Horizontal GSCF (D = 10 m, H = 1 m) Vertical GSCF (D = 10 m, H = 1 m) Vertical GSCF (D = 10 m, H = 1.5 m) Horizontal GSCF (D = 3 m, H = 2 m) Horizontal GSCF (D = 3 m, H = 1 m) Vertical GSCF (D = 3 m, H = 1 m) Vertical GSCF (D = 3 m, H = 1 m) Vertical GSCF (D = 3 m, H = 1 m) | 30 MHz to 300 MHz 300 MHz to 1 GHz 30 MHz to 1 GHz 30 MHz to 1 GHz 30 MHz to 1 GHz 30 MHz to 1 GHz | 1.3 dB 1.1 dB 1.6 dB 1.4 dB 1.7 dB 1.2 dB 1.2 dB 0.9 dB 1.4 dB 1.2 dB 1.5 dB 1.5 dB 1.6 dB 1.6 dB 1.2 dB | |
| Biconical, Log-periodic, Hybrid Antenna Antenna Symmetry | 20 MHz to 300 MHz 300 MHz to 1 GHz 1 GHz to 1.8 GHz | 0.6 dB 0.6 dB 0.5 dB | ANSI C63.5 (OATS Calibration) |
| Horn Antenna Free Space Antenna Factor (D = 3 m) | 0.75 GHz to 8.5 GHz 0.75 GHz to 18 GHz | 1.0 dB 1.2 dB | Standard Site Method ANSI C63.5 , CISPR 16-1-6 Network Analyzer Spectrum Analyzer |
| Loop Antenna – Antenna Factor | 9 kHz to 30 MHz | 1.2 dB | Standard Field Strength Method |
| Large Loop Antenna – Validation Factor Field calibrations available Note 4 | 9 kHz to 30 MHz | 0.8 dB | CISPR 16-1-4 Annex C |
| SCATTERING PARAMETERS | (20/R18) | | |

SCATTERING PARAMETERS (20/R18)

2019-12-09 through 2020-12-31

Effective dates

For the National Voluntary Laboratory Accreditation Program

Page 8 of 12



CALIBRATION LABORATORIES

NVLAP LAB CODE 200012-0

| Impedance & VSWR - Measure Field calibrations available Note 4 | 9 kHz to 300 kHz 300 kHz to 3 GHz 3 GHz to 6 GHz | 2.0 % 1.2 % 2.2 % | Network Analyzer |
|--|--|--|------------------|
| Directional Coupler (9 kHz to 6 GHz) Field calibrations available Note 4 | | | |
| Insertion Loss Coupling Factor | 0 dB to 60 dB 0 dB to 60 dB 60 dB to 70 dB 70 dB to 80 dB | 0.20 dB 0.20 dB 0.44 dB 0.95 dB | Network Analyzer |
| EM Clamp / Decoupling Clamp 0.1 MHz to 230 MHz Field calibrations available Note 4 | 70 dB to 00 dB | 0.55 dB | IEC 61000-4-6 |
| Insertion Loss | 100 kHz to 230 MHz | 0.4 dB | |
| Impedance | 100 kHz to 100 MHz 100 MHz to 230 MHz | 6.0 % 8.8 % | |
| Decoupling Factor | 100 kHz to 100 MHz 100 MHz to 230 MHz | 0.6 dB 0.7 dB | |
| Coupling Factor | 100 kHz to 100 MHz 100 MHz to 230 MHz | 0.7 dB 0.6 dB | |
| 50 ohm to 150 ohm Adaptor 0.1 MHz to 230 MHz Field calibrations available Note 4 | | | Network Analyzer |
| Insertion Loss | 0 dB to 60 dB | 0.3 dB | |
| Current Probe/Current Injection Probe 10 kHz to 500 MHz Field calibrations available Note 4 | | | |
| Insertion Loss Transfer Impedance | 0 dB to 60 dB 0 dB to 60 dB | 0.5 dB 0.5 dB ohm | |
| Calibration Jig of Current Injection Probe Field calibrations available Note 4 | | | |
| Transmission Loss | 150 kHz to 230 MHz | 0.6 dB | IEC 61000-4-6 |

2019-12-09 through 2020-12-31

Effective dates

For the National Voluntary Laboratory Accreditation Program

Page 9 of 12



CALIBRATION LABORATORIES

NVLAP LAB CODE 200012-0

| Hi-Impedance Probe 9 kHz to 30 MHz Field calibrations available Note 4 Voltage Division Factor (VDF) | 0 dB to 60 dB | 0.3 dB | | |
|---|--|-----------------------------------|--|--|
| RF Insertion Loss/Gain Measure Field calibrations available Note 4 9 kHz to 300 kHz 300 kHz to 3 GHz 3 GHz to 6 GHz | 0 dB to 60 dB | 0.20 dB 0.10 dB 0.13 dB | | |
| LISN Field calibrations available Note 4 | | | CISPR 16-1-2, CISPR 25, ISO 7637-1 and -2 ANSI C63.4 | |
| Insertion Loss/VDF | 9 kHz to 108 MHz | 0.2 dB | ANSI C03.4 | |
| Impedance | 9 kHz to 30 MHz 30 MHz to 108 MHz | 2.1 % 3.3 % | | |
| Phase | 9 kHz to 30 MHz 30 MHz to 108 MHz | 4.9° 6.6° | | |
| Isolation | 9 kHz to 108 MHz | 2.9 dB | | |
| CDN Field calibrations available Note 4 Insertion Loss | 100 kHz to 230 MHz | 0.2 dB | | |
| Impedance | 100 kHz to 80 MHz 80 MHz to 230 MHz | 1.4 % 2.1 % | | |
| CMAD Field calibrations available Note 4 Transmission Coefficient Reflection Coefficient | 30 MHz to 200 MHz 30 MHz to 200 MHz | 0.0051 (linear) 0.013 (linear) | | |
| END | | | | |

2019-12-09 through 2020-12-31

Effective dates

For the National Voluntary Laboratory Accreditation Program

Page 10 of 12



CALIBRATION LABORATORIES

NVLAP LAB CODE 200012-0

2019-12-09 through 2020-12-31

Effective dates

For the National Voluntary Laboratory Accreditation Program

Page 11 of 12



CALIBRATION LABORATORIES

NVLAP LAB CODE 200012-0

Notes

Note 1: A Calibration and Measurement Capability (CMC) is a description of the best result of a calibration or measurement (result with the smallest uncertainty of measurement) that is available to the laboratory's customers under normal conditions, when performing more or less routine calibrations of nearly ideal measurement standards or instruments. The CMC is described in the laboratory's scope of accreditation by: the measurement parameter/device being calibrated, the measurement range, the uncertainty associated with that range (see note 3), and remarks on additional parameters, if applicable.

Note 2: Calibration and Measurement Capabilities are traceable to the national measurement standards of the U.S. or to the national measurement standards of other countries and are thus traceable to the internationally accepted representation of the appropriate SI (Système International) unit.

Note 3: The uncertainty associated with a measurement in a CMC is an expanded uncertainty with a level of confidence of approximately 95 %, typically using a coverage factor of k = 2. However, laboratories may report a coverage factor different than k = 2 to achieve the 95 % level of confidence. Units for the measurand and its uncertainty are to match. Exceptions to this occur when marketplace practice employs mixed units, such as when the artifact to be measured is labeled in non-SI units and the uncertainty is given in SI units (Example: 5 lb weight with uncertainty given in mg).

Note 3a: The uncertainty of a specific calibration by the laboratory may be greater than the uncertainty in the CMC due to the condition and behavior of the customer's device and specific circumstances of the calibration. The uncertainties quoted do not include possible effects on the calibrated device of transportation, long term stability, or intended use.

Note 3b: As the CMC represents the best measurement results achievable under normal conditions, the accredited calibration laboratory shall not report smaller uncertainty of measurement than that given in a CMC for calibrations or measurements covered by that CMC.

Note 3c: As described in Note 1, CMCs cover calibrations and measurements that are available to the laboratory's customers under *normal conditions*. However, the laboratory may have the capability to offer special tests, employing special conditions, which yield calibration or measurement results with lower uncertainties. Such special tests are not covered by the CMCs and are outside the laboratory's scope of accreditation. In this case, NVLAP requirements for the labeling, on calibration reports, of results outside the laboratory's scope of accreditation apply. These requirements are set out in Annex A.1.h. of NIST Handbook 150, Procedures and General Requirements.

Note 4: Uncertainties associated with field service calibration may be greater as they incorporate on-site environmental contributions, transportation effects, or other factors that affect the measurements. (This note applies only if marked in the body of the scope.)

Note 5: Values listed with percent (%) are percent of reading or generated value unless otherwise noted.

Note 6: NVLAP accreditation is the formal recognition of specific calibration capabilities. Neither NVLAP nor NIST guarantee the accuracy of individual calibrations made by accredited laboratories.

2019-12-09 through 2020-12-31

Effective dates

For the National Voluntary Laboratory Accreditation Program

Page 12 of 12